Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,519	LEE ET AL.	
Examiner	Art Unit	
Tu T Nauven	2977	

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Class	Subclass	Date	Examiner
356	237.1>	7/26/2005	TN
	237.6	7/26/2005	TN
	239.1>	7/26/2005	TN
	239.8	7/26/2005	TN
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